

# Wavelet Methods for Time Series Analysis

## Part VIII: Wavelet-Based Analysis and Synthesis of Long Memory Processes

- DWT well-suited for long memory processes (LMPs)
- basic idea: DWT approximately decorrelates LMPs
- on synthesis side, leads to DWT-based simulation of LMPs
- on analysis side, leads to wavelet-based maximum likelihood and least squares estimators for LMP parameters, along with a test for homogeneity of variance

## Wavelets and Long Memory Processes: I

- wavelet filters are approximate band-pass filters, with nominal pass-bands  $[1/2^{j+1}, 1/2^j]$  (called  $j$ th ‘octave band’)
- suppose  $\{X_t\}$  has  $S_X(\cdot)$  as its spectral density function (SDF)
- statistical properties of  $\{W_{j,t}\}$  are simple if  $S_X(\cdot)$  has simple structure within  $j$ th octave band
- example: fractionally differenced (FD) process

$$(1 - B)^\delta X_t = \varepsilon_t,$$

(where  $B$  is the backward shift operator such that  $(1 - B)X_t = X_t - X_{t-1}$ ) having SDF

$$S_X(f) = \sigma_\varepsilon^2 / [4 \sin^2(\pi f)]^\delta$$

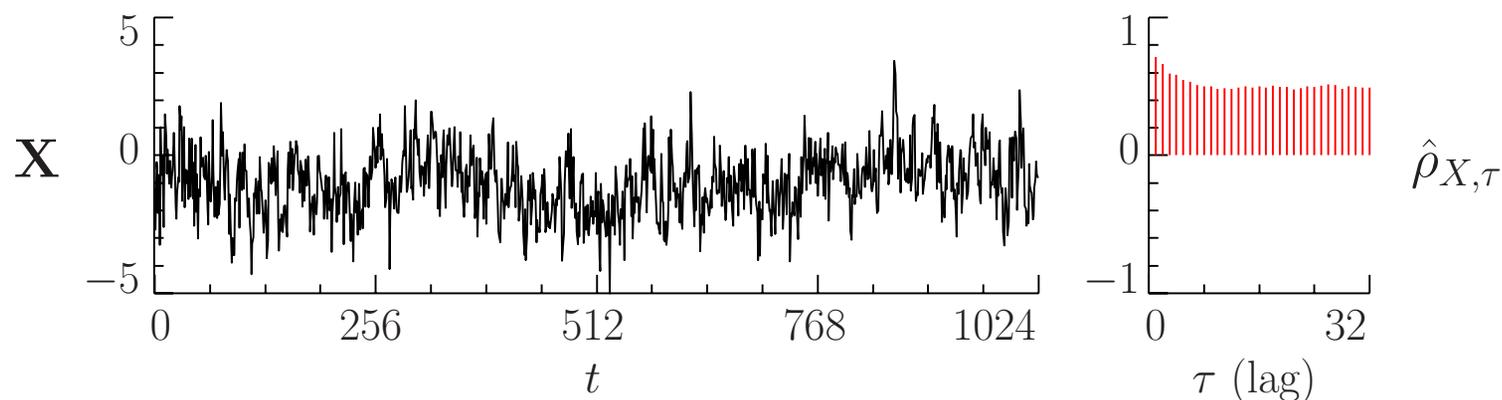
## Wavelets and Long Memory Processes: II

- FD process controlled by two parameters:  $\delta$  and  $\sigma_\varepsilon^2$
- for small  $f$ , have  $S_X(f) \approx C|f|^{-2\delta}$ ; i.e., a power law
- $\log(S_X(f))$  vs.  $\log(f)$  is approximately linear with slope  $-2\delta$
- for large  $\tau_j$ , the wavelet variance at scale  $\tau_j$ , namely  $\nu_X^2(\tau_j)$ , satisfies  $\nu_X^2(\tau_j) \approx C'\tau_j^{2\delta-1}$
- $\log(\nu_X^2(\tau_j))$  vs.  $\log(\tau_j)$  is approximately linear, slope  $2\delta - 1$
- approximately ‘self-similar’ (or ‘fractal’)
- stationary ‘long memory’ process (LMP) if  $0 < \delta < 1/2$ : correlation between  $X_t$  and  $X_{t+\tau}$  dies down slowly as  $\tau$  increases

## Wavelets and Long Memory Processes: III

- power law model ubiquitous in physical sciences
  - voltage fluctuations across cell membranes
  - traffic fluctuations on an expressway
  - impedance fluctuations in geophysical borehole
  - fluctuations in the rotation of the earth
  - X-ray time variability of galaxies
- DWT well-suited to study FD process and other LMPs
  - ‘self-similar’ filters used on ‘self-similar’ processes
  - key idea: DWT approximately decorrelates LMPs

## DWT of a Long Memory Process: I

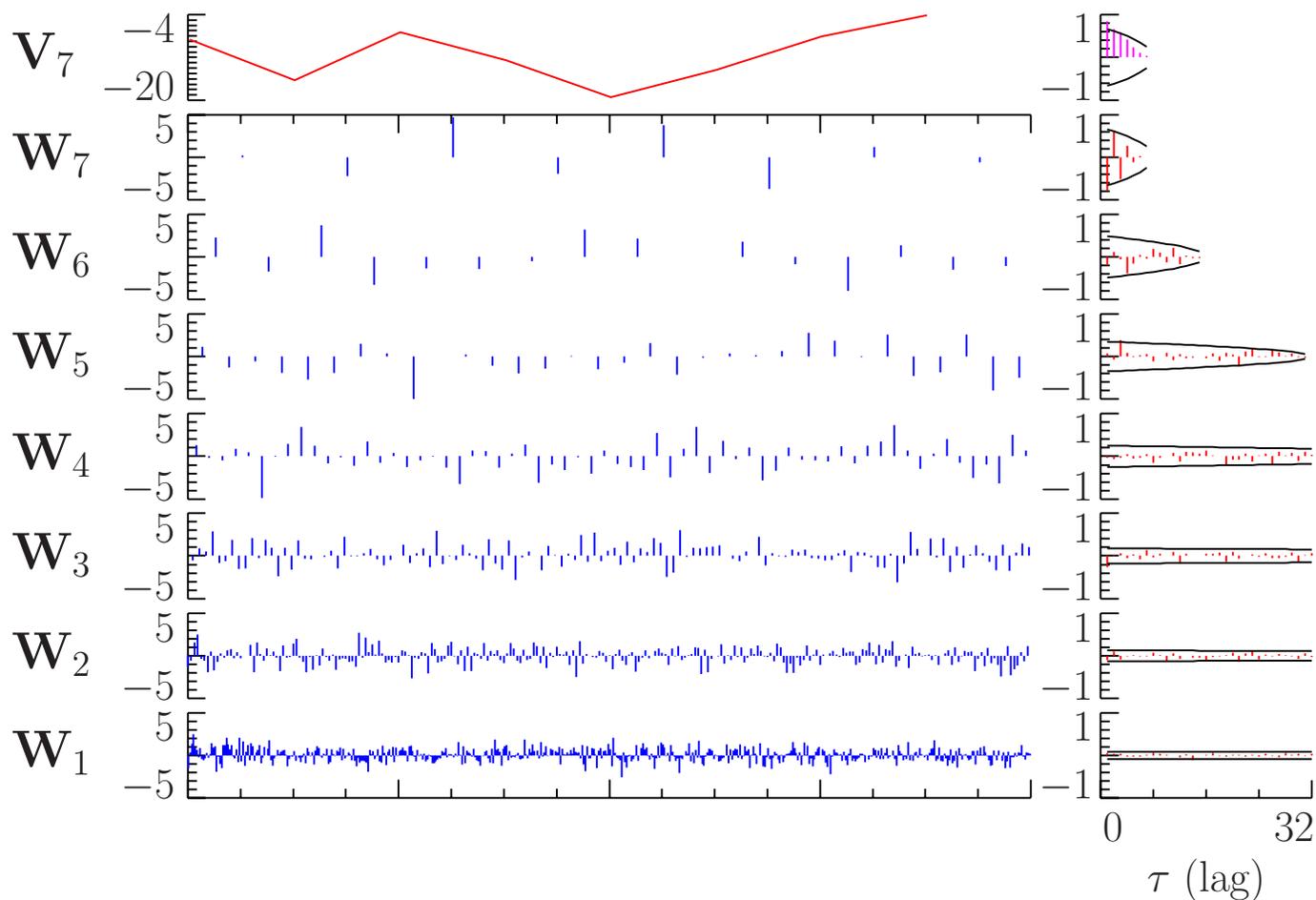


- realization of an FD(0.4) time series  $\mathbf{X}$  along with its sample autocorrelation sequence (ACS): for  $\tau \geq 0$ ,

$$\hat{\rho}_{X,\tau} \equiv \frac{\sum_{t=0}^{N-1-\tau} X_t X_{t+\tau}}{\sum_{t=0}^{N-1} X_t^2}$$

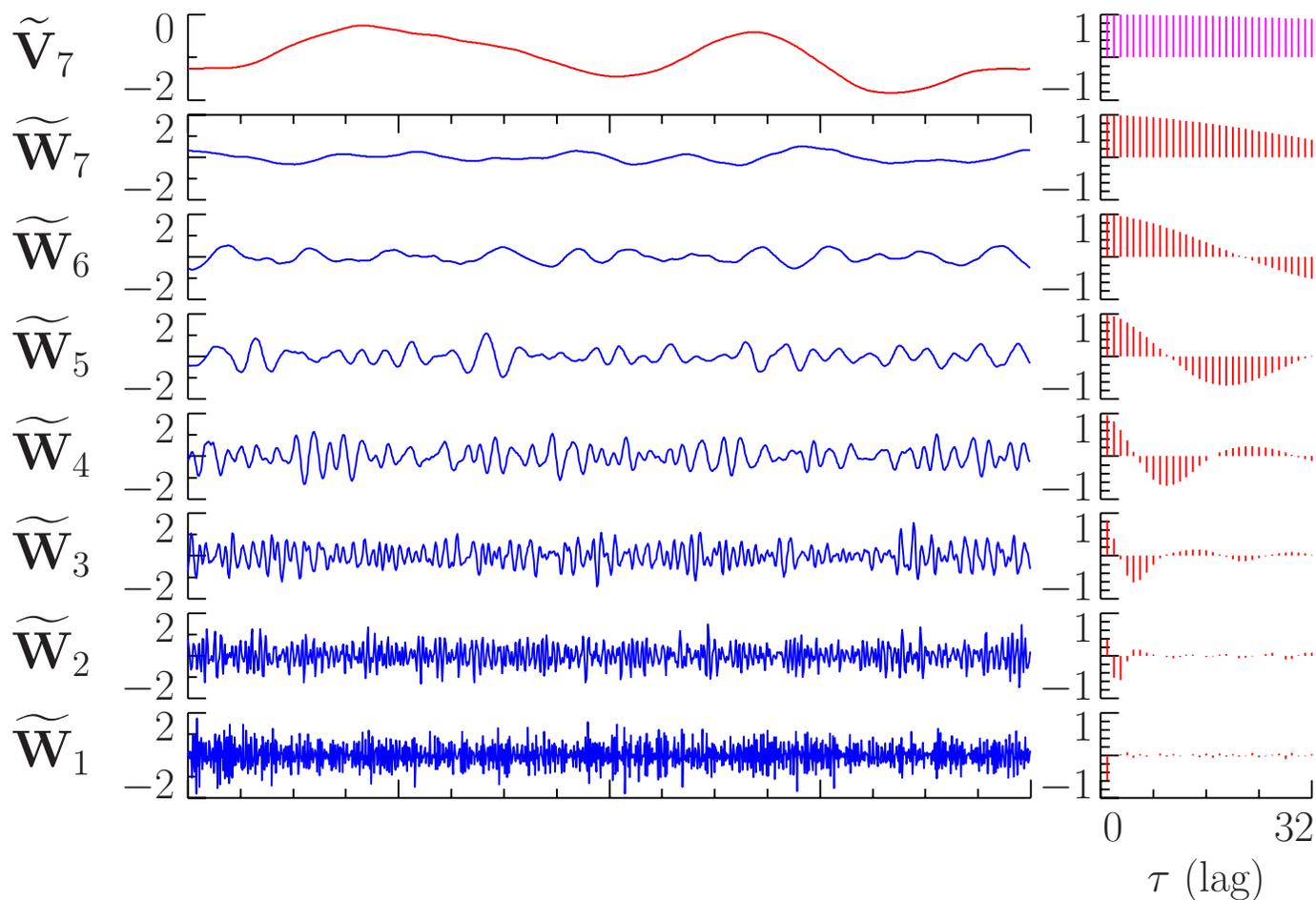
- note that ACS dies down slowly

## DWT of a Long Memory Process: II



- LA(8) DWT of FD(0.4) series and sample ACSs for each  $W_j$  &  $V_7$ , along with 95% confidence intervals for white noise

## MODWT of a Long Memory Process



- LA(8) MODWT of FD(0.4) series & sample ACSs for MODWT coefficients, none of which are approximately uncorrelated

## DWT of a Long Memory Process: III

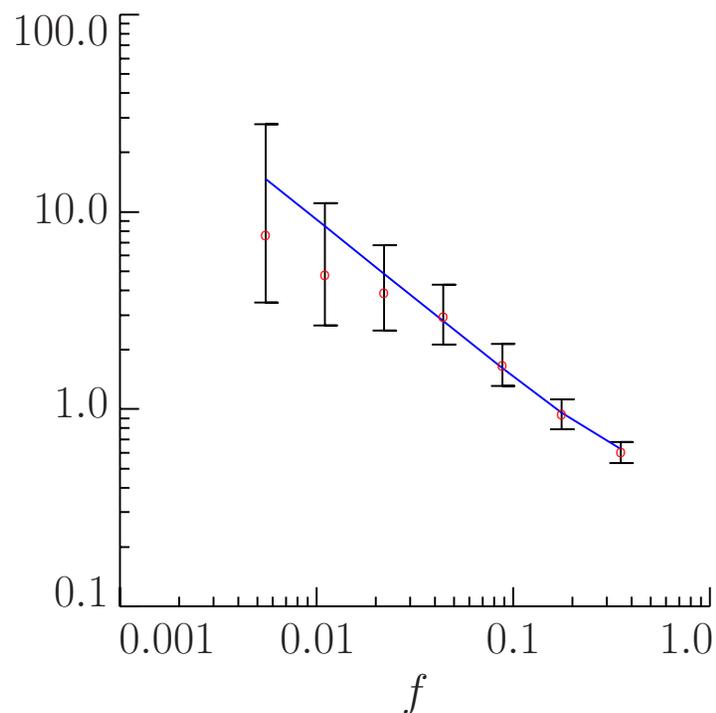
- in contrast to  $\mathbf{X}$ , ACSs for  $\mathbf{W}_j$  consistent with white noise
- variance of  $\mathbf{W}_j$  increases with  $j$  – to see why, note that

$$\begin{aligned} \text{var} \{W_{j,t}\} &= \int_{-1/2}^{1/2} \mathcal{H}_j(f) S_X(f) df \\ &\approx 2 \int_{1/2^{j+1}}^{1/2^j} 2^j S_X(f) df \\ &= \frac{1}{\frac{1}{2^j} - \frac{1}{2^{j+1}}} \int_{1/2^{j+1}}^{1/2^j} S_X(f) df \equiv C_j, \end{aligned}$$

where  $C_j$  is average value of  $S_X(\cdot)$  over  $[1/2^{j+1}, 1/2^j]$

- for FD process, can argue that  $C_j \approx S_X(1/2^{j+\frac{1}{2}})$ , where  $1/2^{j+\frac{1}{2}}$  is midpoint of interval  $[1/2^{j+1}, 1/2^j]$

## DWT of a Long Memory Process: IV



- plot shows  $\widehat{\text{var}}\{W_{j,t}\}$  (circles) &  $S_X(1/2^{j+1/2})$  (curve) versus  $1/2^{j+1/2}$ , along with 95% confidence intervals for  $\text{var}\{W_{j,t}\}$
- observed  $\widehat{\text{var}}\{W_{j,t}\}$  agrees well with theoretical  $\text{var}\{W_{j,t}\}$

## Correlations Within a Scale and Between Two Scales

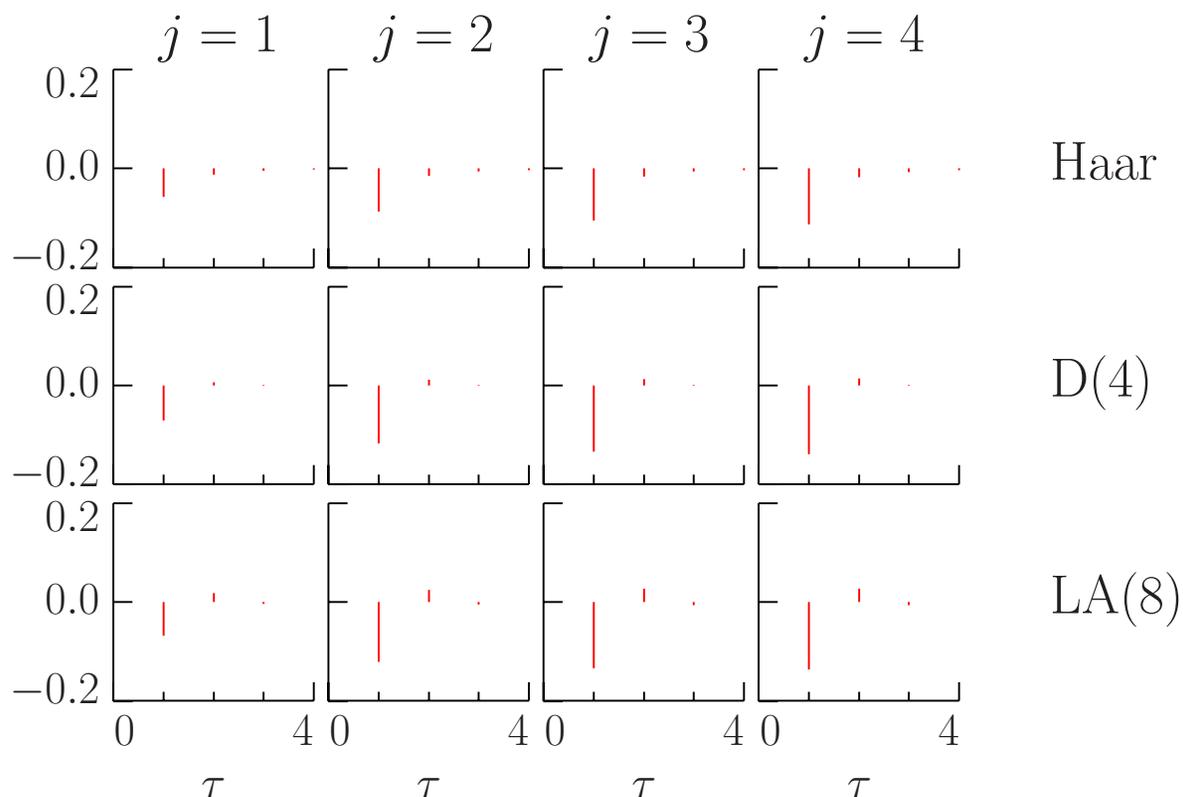
- let  $\{s_{X,\tau}\}$  denote autocovariance sequence (ACVS) for  $\{X_t\}$ ; i.e.,  $s_{X,\tau} = \text{cov}\{X_t, X_{t+\tau}\}$
- let  $\{h_{j,l}\}$  denote equivalent wavelet filter for  $j$ th level
- to quantify decorrelation, can write

$$\text{cov}\{W_{j,t}, W_{j',t'}\} = \sum_{l=0}^{L_j-1} \sum_{l'=0}^{L_{j'}-1} h_{j,l} h_{j',l'} s_{X,2^j(t+1)-l-2^{j'}(t'+1)+l'}$$

from which we can get ACVS (and hence within-scale correlations) for  $\{W_{j,t}\}$ :

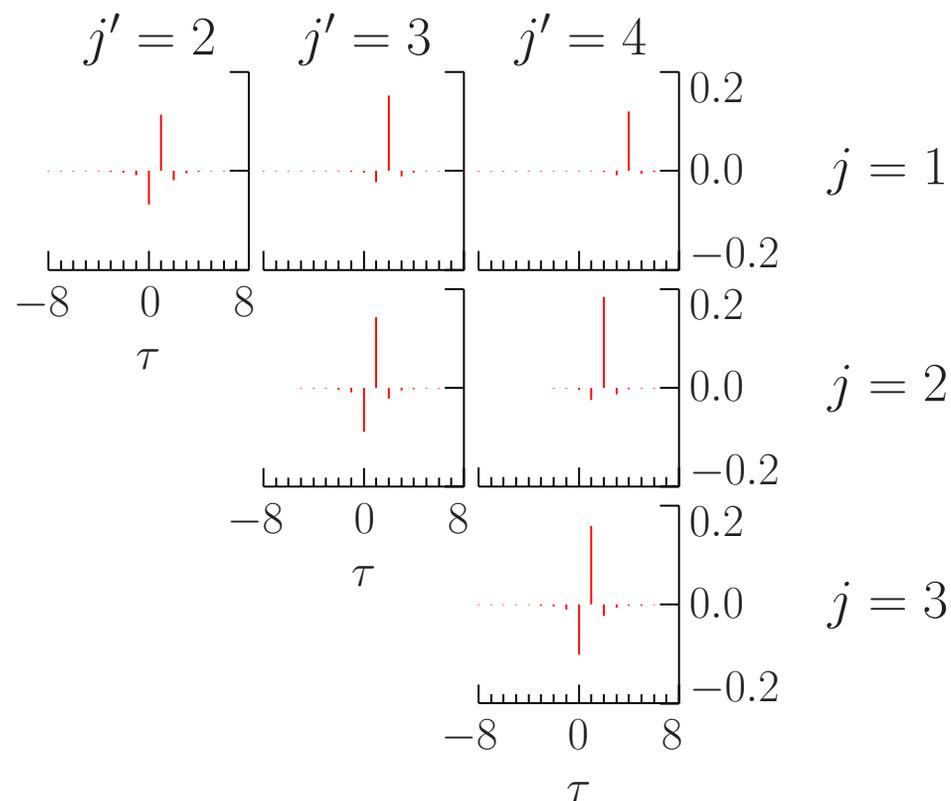
$$\text{cov}\{W_{j,t}, W_{j,t+\tau}\} = \sum_{m=-(L_j-1)}^{L_j-1} s_{X,2^j\tau+m} \sum_{l=0}^{L_j-|m|-1} h_{j,l} h_{j,l+|m|}$$

## Correlations Within a Scale



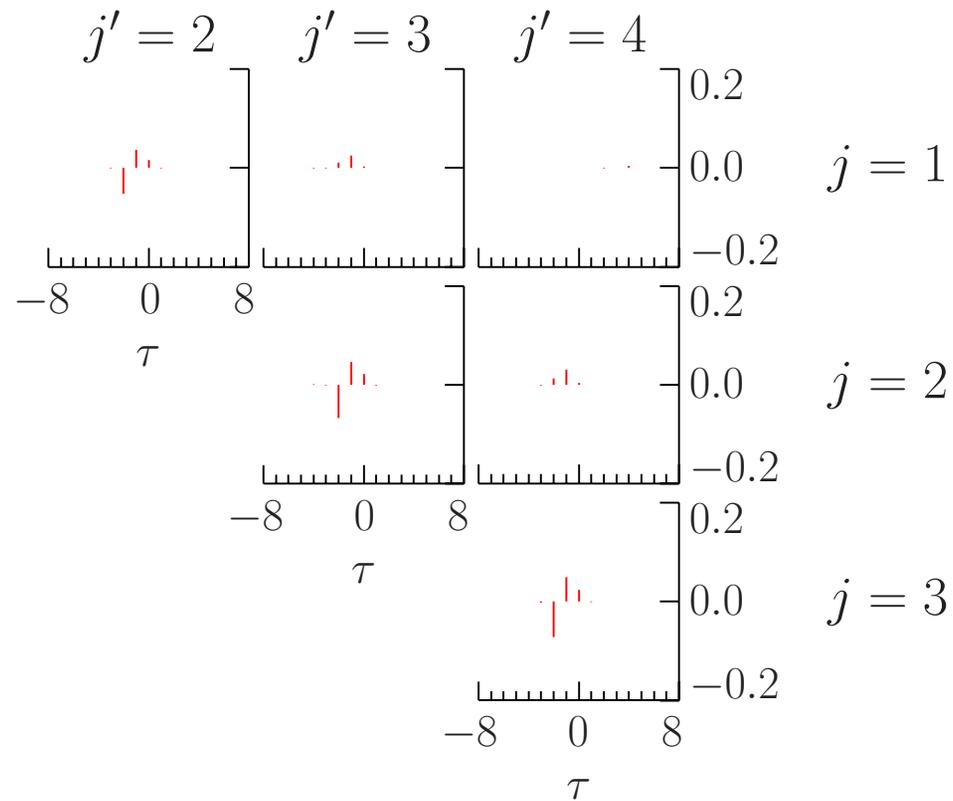
- correlations between  $W_{j,t}$  and  $W_{j,t+\tau}$  for an FD(0.4) process
- correlations within scale are slightly smaller for Haar
- maximum magnitude of correlation is less than 0.2

## Correlations Between Two Scales: I



- correlation between Haar wavelet coefficients  $W_{j,t}$  and  $W_{j',t'}$  from FD(0.4) process and for levels satisfying  $1 \leq j < j' \leq 4$

## Correlations Between Two Scales: II



- same as before, but now for LA(8) wavelet coefficients
- correlations between scales decrease as  $L$  increases

## Wavelet Domain Description of FD Process

- DWT acts as a decorrelating transform for FD process (also true for fractional Gaussian noise, pure power law etc.)
- wavelet domain description is simple
- wavelet coefficients within a given scale are approximately uncorrelated (refinement: assume 1st order autoregressive model)
- wavelet coefficients have a scale-dependent variance, but these variances are controlled by the two FD parameters ( $\delta$  and  $\sigma_\varepsilon^2$ )
- wavelet coefficients between scales are also approximately uncorrelated (approximation improves as filter width  $L$  increases)

## DWT-Based Simulation

- properties of DWT of FD processes lead to schemes for simulating time series  $\mathbf{X} \equiv [X_0, \dots, X_{N-1}]^T$  with zero mean and with a multivariate Gaussian distribution
- with  $N = 2^J$ , recall that  $\mathbf{X} = \mathcal{W}^T \mathbf{W}$ , where

$$\mathbf{W} = \begin{bmatrix} \mathbf{W}_1 \\ \mathbf{W}_2 \\ \vdots \\ \mathbf{W}_j \\ \vdots \\ \mathbf{W}_J \\ \mathbf{V}_J \end{bmatrix}$$

## Basic DWT-Based Simulation Scheme

- assume  $\mathbf{W}$  to contain  $N$  uncorrelated Gaussian (normal) random variables (RVs) with zero mean
- assume  $\mathbf{W}_j$  to have variance  $C_j \approx S_X(1/2^{j+\frac{1}{2}})$
- assume single RV in  $\mathbf{V}_J$  to have variance  $C_{J+1}$  (see textbook for details about how to set  $C_{J+1}$ )
- approximate FD time series  $\mathbf{X}$  via  $\mathbf{Y} \equiv \mathcal{W}^T \Lambda^{1/2} \mathbf{Z}$ , where
  - $\Lambda^{1/2}$  is  $N \times N$  diagonal matrix with diagonal elements
 
$$\underbrace{C_1^{1/2}, \dots, C_1^{1/2}}_{\frac{N}{2} \text{ of these}}, \underbrace{C_2^{1/2}, \dots, C_2^{1/2}}_{\frac{N}{4} \text{ of these}}, \dots, \underbrace{C_{J-1}^{1/2}, C_{J-1}^{1/2}}_{2 \text{ of these}}, C_J^{1/2}, C_{J+1}^{1/2}$$
  - $\mathbf{Z}$  is vector of deviations drawn from a Gaussian distribution with zero mean and unit variance

## Refinements to Basic Scheme: I

- covariance matrix for approximation  $\mathbf{Y}$  does not correspond to that of a stationary process
- recall  $\mathcal{W}$  treats  $\mathbf{X}$  as if it were circular
- let  $\mathcal{T}$  be  $N \times N$  ‘circular shift’ matrix:

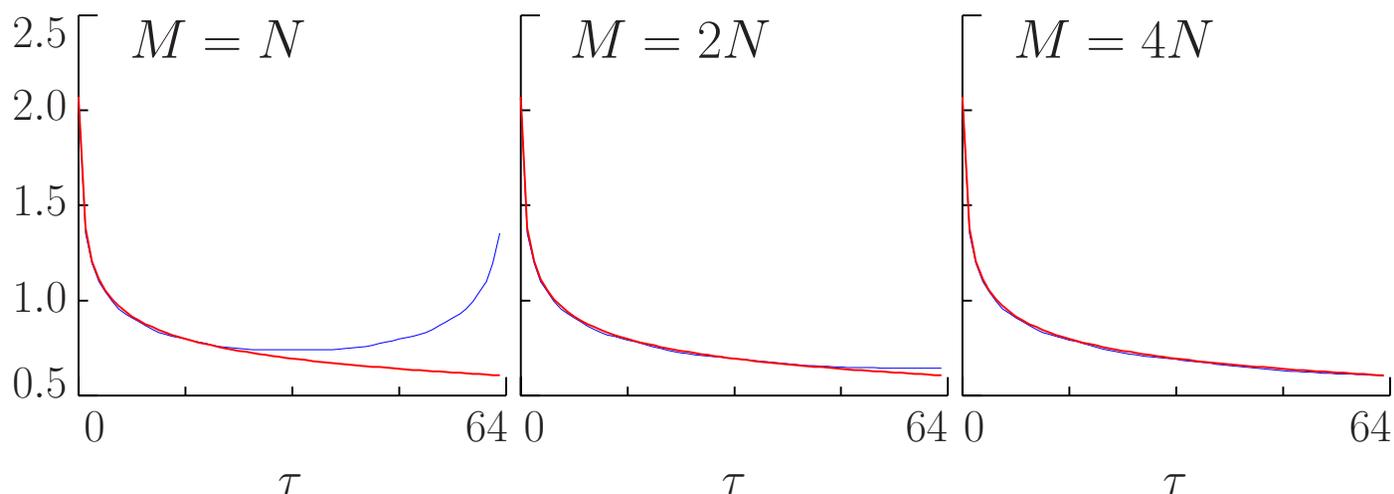
$$\mathcal{T} \begin{bmatrix} Y_0 \\ Y_1 \\ Y_2 \\ Y_3 \end{bmatrix} = \begin{bmatrix} Y_1 \\ Y_2 \\ Y_3 \\ Y_0 \end{bmatrix}; \quad \mathcal{T}^2 \begin{bmatrix} Y_0 \\ Y_1 \\ Y_2 \\ Y_3 \end{bmatrix} = \begin{bmatrix} Y_2 \\ Y_3 \\ Y_0 \\ Y_1 \end{bmatrix}; \quad \text{etc.}$$

- let  $\kappa$  be uniformly distributed over  $0, \dots, N - 1$
- define  $\tilde{\mathbf{Y}} \equiv \mathcal{T}^\kappa \mathbf{Y}$
- $\tilde{\mathbf{Y}}$  is stationary with ACVS given by, say,  $s_{\tilde{\mathbf{Y}}, \tau}$

## Refinements to Basic Scheme: II

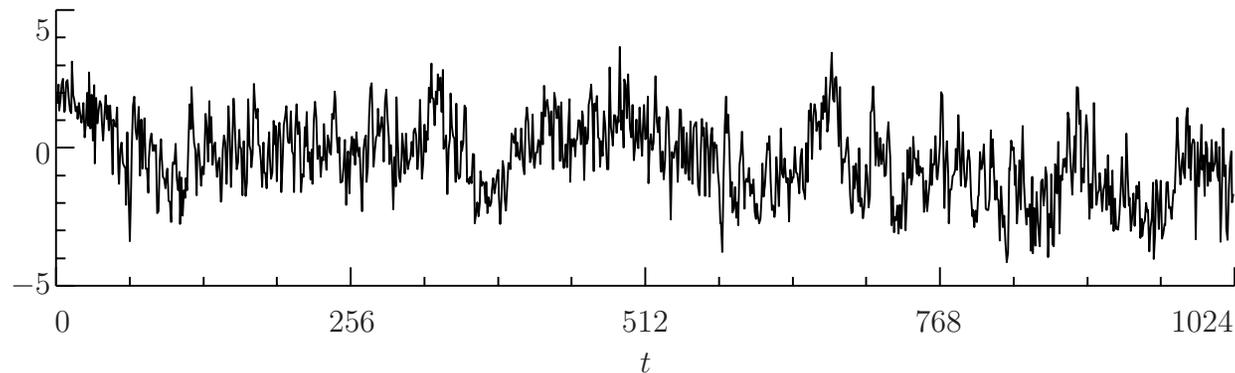
- Q: how well does  $\{s_{\tilde{Y},\tau}\}$  match  $\{s_{X,\tau}\}$ ?
- due to circularity, find that  $s_{\tilde{Y},N-\tau} = s_{\tilde{Y},\tau}$  for  $\tau = 1, \dots, N/2$
- implies  $s_{\tilde{Y},\tau}$  cannot approximate  $s_{X,\tau}$  well for  $\tau$  close to  $N$
- can patch up by simulating  $\tilde{\mathbf{Y}}$  with  $M > N$  elements and then extracting first  $N$  deviates ( $M = 4N$  works well)

## Refinements to Basic Scheme: III



- plot shows **true** ACVS  $\{s_{X,\tau}\}$  (**thick** curves) for FD(0.4) process and wavelet-based **approximate** ACVSs  $\{s_{\tilde{Y},\tau}\}$  (**thin** curves) based on an LA(8) DWT in which an  $N = 64$  series is extracted from  $M = N$ ,  $M = 2N$  and  $M = 4N$  series

## Example and Some Notes



- simulated FD(0.4) series (LA(8),  $N = 1024$  and  $M = 4N$ )
- notes:
  - can form realizations faster than best exact method
  - efficient ‘real-time’ simulation of extremely long time series (e.g,  $N = 2^{30} = 1,073,741,824$  or even longer)
  - effect of random circular shifting is to render time series non-Gaussian (a Gaussian mixture model)

## MLEs of FD Parameters: I

- FD process depends on 2 parameters, namely,  $\delta$  and  $\sigma_\varepsilon^2$ :

$$S_X(f) = \frac{\sigma_\varepsilon^2}{[4 \sin^2(\pi f)]^\delta}$$

- given  $\mathbf{X} = [X_0, X_1, \dots, X_{N-1}]^T$  with  $N = 2^J$ , suppose we want to estimate  $\delta$  and  $\sigma_\varepsilon^2$
- if  $\mathbf{X}$  is stationary (i.e.  $\delta < 1/2$ ) and multivariate Gaussian, can use the maximum likelihood (ML) method

## MLEs of FD Parameters: II

- definition of Gaussian likelihood function:

$$L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X}) \equiv \frac{1}{(2\pi)^{N/2} |\Sigma_{\mathbf{X}}|^{1/2}} e^{-\mathbf{X}^T \Sigma_{\mathbf{X}}^{-1} \mathbf{X} / 2}$$

where  $\Sigma_{\mathbf{X}}$  is covariance matrix for  $\mathbf{X}$ , with  $(s, t)$ th element given by  $s_{X, s-t}$ , and  $|\Sigma_{\mathbf{X}}|$  &  $\Sigma_{\mathbf{X}}^{-1}$  denote determinant & inverse

- ML estimators of  $\delta$  and  $\sigma_\varepsilon^2$  maximize  $L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X})$  or, equivalently, minimize

$$-2 \log (L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X})) = N \log (2\pi) + \log (|\Sigma_{\mathbf{X}}|) + \mathbf{X}^T \Sigma_{\mathbf{X}}^{-1} \mathbf{X}$$

- exact MLEs computationally intensive, mainly because of the need to invert  $\Sigma_{\mathbf{X}}$  and compute its determinant
- good approximate MLEs of considerable interest

## MLEs of FD Parameters: III

- key ideas behind first wavelet-based approximate MLEs
  - have seen that we can approximate FD time series  $\mathbf{X}$  by  $\mathbf{Y} = \mathcal{W}^T \Lambda^{1/2} \mathbf{Z}$ , where  $\Lambda^{1/2}$  is a diagonal matrix, all of whose diagonal elements are positive
  - since covariance matrix for  $\mathbf{Z}$  is  $I_N$ , Equation (262c) says covariance matrix for  $\mathbf{Y}$  is
$$\mathcal{W}^T \Lambda^{1/2} I_N (\mathcal{W}^T \Lambda^{1/2})^T = \mathcal{W}^T \Lambda^{1/2} \Lambda^{1/2} \mathcal{W} = \mathcal{W}^T \Lambda \mathcal{W} \equiv \tilde{\Sigma}_{\mathbf{X}},$$
where  $\Lambda \equiv \Lambda^{1/2} \Lambda^{1/2}$  is also diagonal
  - can consider  $\tilde{\Sigma}_{\mathbf{X}}$  to be an approximation to  $\Sigma_{\mathbf{X}}$
- leads to approximation of log likelihood:
$$-2 \log (L(\delta, \sigma_\varepsilon^2 \mid \mathbf{X})) \approx N \log (2\pi) + \log (|\tilde{\Sigma}_{\mathbf{X}}|) + \mathbf{X}^T \tilde{\Sigma}_{\mathbf{X}}^{-1} \mathbf{X}$$

## MLEs of FD Parameters: IV

- Q: so how does this help us?

- easy to invert  $\tilde{\Sigma}_{\mathbf{X}}$ :

$$\tilde{\Sigma}_{\mathbf{X}}^{-1} = (\mathcal{W}^T \Lambda \mathcal{W})^{-1} = (\mathcal{W})^{-1} \Lambda^{-1} (\mathcal{W}^T)^{-1} = \mathcal{W}^T \Lambda^{-1} \mathcal{W},$$

where  $\Lambda^{-1}$  is another diagonal matrix, leading to

$$\mathbf{X}^T \tilde{\Sigma}_{\mathbf{X}}^{-1} \mathbf{X} = \mathbf{X}^T \mathcal{W}^T \Lambda^{-1} \mathcal{W} \mathbf{X} = \mathbf{W}^T \Lambda^{-1} \mathbf{W}$$

- easy to compute the determinant of  $\tilde{\Sigma}_{\mathbf{X}}$ :

$$|\tilde{\Sigma}_{\mathbf{X}}| = |\mathcal{W}^T \Lambda \mathcal{W}| = |\Lambda \mathcal{W} \mathcal{W}^T| = |\Lambda I_N| = |\Lambda| \cdot |I_N| = |\Lambda|,$$

and the determinant of a diagonal matrix is just the product of its diagonal elements

## MLEs of FD Parameters: V

- define the following three functions of  $\delta$ :

$$C'_j(\delta) \equiv \int_{1/2^{j+1}}^{1/2^j} \frac{2^{j+1}}{[4 \sin^2(\pi f)]^\delta} df \approx \int_{1/2^{j+1}}^{1/2^j} \frac{2^{j+1}}{[2\pi f]^{2\delta}} df$$

$$C'_{J+1}(\delta) \equiv \frac{N\Gamma(1-2\delta)}{\Gamma^2(1-\delta)} - \sum_{j=1}^J \frac{N}{2^j} C'_j(\delta)$$

$$\sigma_\varepsilon^2(\delta) \equiv \frac{1}{N} \left( \frac{V_{J,0}^2}{C'_{J+1}(\delta)} + \sum_{j=1}^J \frac{1}{C'_j(\delta)} \sum_{t=0}^{\frac{N}{2^j}-1} W_{j,t}^2 \right)$$

## MLEs of FD Parameters: VI

- wavelet-based approximate MLE  $\tilde{\delta}$  for  $\delta$  is the value that minimizes the following function of  $\delta$ :

$$\tilde{l}(\delta \mid \mathbf{X}) \equiv N \log(\sigma_{\varepsilon}^2(\delta)) + \log(C'_{J+1}(\delta)) + \sum_{j=1}^J \frac{N}{2^j} \log(C'_j(\delta)),$$

- once  $\tilde{\delta}$  has been determined, MLE for  $\sigma_{\varepsilon}^2$  is given by  $\sigma_{\varepsilon}^2(\tilde{\delta})$
- computer experiments indicate scheme works quite well

## LSEs of FD Parameters

- one alternative to MLEs are least square estimators (LSEs)

- recall that, for large  $\tau$  and for  $\beta = 2\delta - 1$ ,

$$\log(\nu_X^2(\tau_j)) \approx \zeta + \beta \log(\tau_j)$$

- suggests determining  $\delta$  by regressing  $\log(\hat{\nu}_X^2(\tau_j))$  on  $\log(\tau_j)$  over range of  $\tau_j$

- weighted LSE takes into account fact that variance of  $\log(\hat{\nu}_X^2(\tau_j))$  depends upon scale  $\tau_j$  (increases as  $\tau_j$  increases)

## Homogeneity of Variance: I

- because DWT decorrelates LMPs, nonboundary coefficients in  $\mathbf{W}_j$  should resemble white noise; i.e.,  $\text{cov}\{W_{j,t}, W_{j,t'}\} \approx 0$  when  $t \neq t'$ , and  $\text{var}\{W_{j,t}\}$  should not depend upon  $t$
- can test for homogeneity of variance in  $\mathbf{X}$  using  $\mathbf{W}_j$  at each level  $j$
- suppose  $U_0, \dots, U_{N-1}$  are independent normal RVs with  $E\{U_t\} = 0$  and  $\text{var}\{U_t\} = \sigma_t^2$
- want to test null hypothesis

$$H_0 : \sigma_0^2 = \sigma_1^2 = \dots = \sigma_{N-1}^2$$

- can test  $H_0$  versus a variety of alternatives, e.g.,

$$H_1 : \sigma_0^2 = \dots = \sigma_k^2 \neq \sigma_{k+1}^2 = \dots = \sigma_{N-1}^2$$

using normalized cumulative sum of squares

## Homogeneity of Variance: II

- to define test statistic  $D$ , start with

$$\mathcal{P}_k \equiv \frac{\sum_{j=0}^k U_j^2}{\sum_{j=0}^{N-1} U_j^2}, \quad k = 0, \dots, N-2$$

and then compute  $D \equiv \max(D^+, D^-)$ , where

$$D^+ \equiv \max_{0 \leq k \leq N-2} \left( \frac{k+1}{N-1} - \mathcal{P}_k \right) \quad \& \quad D^- \equiv \max_{0 \leq k \leq N-2} \left( \mathcal{P}_k - \frac{k}{N-1} \right)$$

- can reject  $H_0$  if observed  $D$  is ‘too large,’ where ‘too large’ is quantified by considering distribution of  $D$  under  $H_0$
- need to find critical value  $x_\alpha$  such that  $\mathbf{P}[D \geq x_\alpha] = \alpha$  for, e.g.,  $\alpha = 0.01, 0.05$  or  $0.1$

## Homogeneity of Variance: III

- once determined, can perform  $\alpha$  level test of  $H_0$ :
  - compute  $D$  statistic from data  $U_0, \dots, U_{N-1}$
  - reject  $H_0$  at level  $\alpha$  if  $D \geq x_\alpha$
  - fail to reject  $H_0$  at level  $\alpha$  if  $D < x_\alpha$
- can determine critical values  $x_\alpha$  in two ways
  - Monte Carlo simulations
  - large sample approximation to distribution of  $D$ :

$$\mathbf{P}[(N/2)^{1/2}D \geq x] \approx 1 + 2 \sum_{l=1}^{\infty} (-1)^l e^{-2l^2 x^2}$$

(reasonable approximation for  $N \geq 128$ )

## Homogeneity of Variance: IV

- idea: given time series  $\{X_t\}$ , compute  $D$  using nonboundary wavelet coefficients  $W_{j,t}$  (there are  $M'_j \equiv N_j - L'_j$  of these):

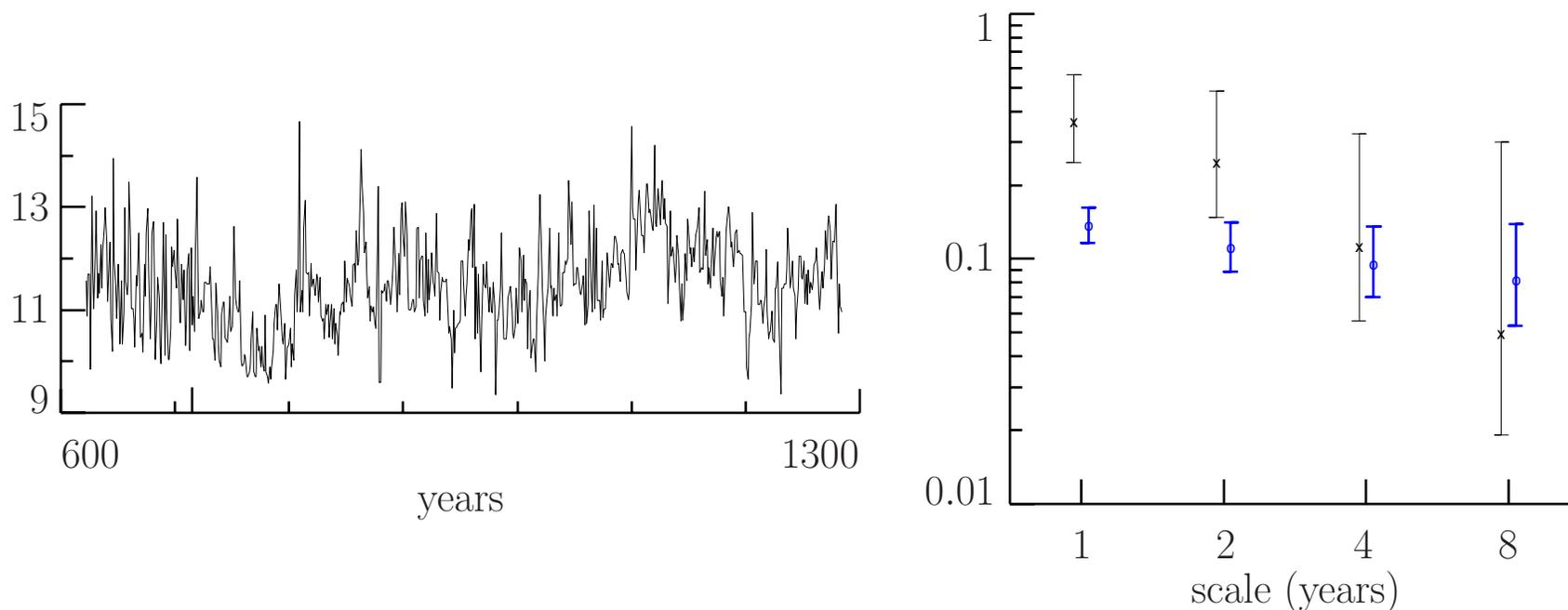
$$\mathcal{P}_k \equiv \frac{\sum_{t=L'_j}^k W_{j,t}^2}{\sum_{t=L'_j}^{N_j-1} W_{j,t}^2}, \quad k = L'_j, \dots, N_j - 2$$

- if null hypothesis rejected at level  $j$ , can use nonboundary MODWT coefficients to accurately locate change point based on

$$\tilde{\mathcal{P}}_k \equiv \frac{\sum_{t=L_j-1}^k \widetilde{W}_{j,t}^2}{\sum_{t=L_j-1}^{N-1} \widetilde{W}_{j,t}^2}, \quad k = L_j - 1, \dots, N - 2$$

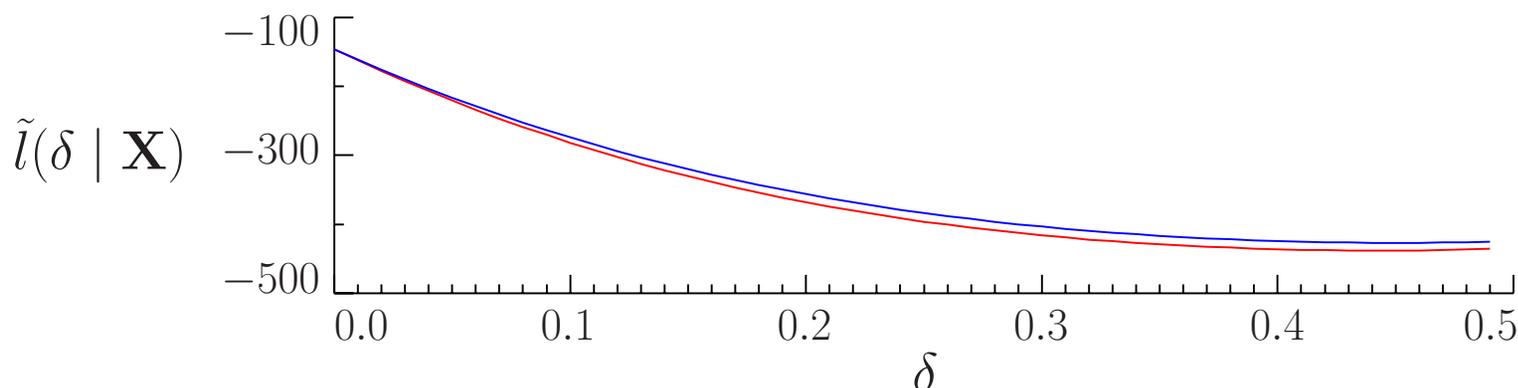
along with analogs  $\tilde{D}_k^+$  and  $\tilde{D}_k^-$  of  $D_k^+$  and  $D_k^-$

## Annual Minima of Nile River



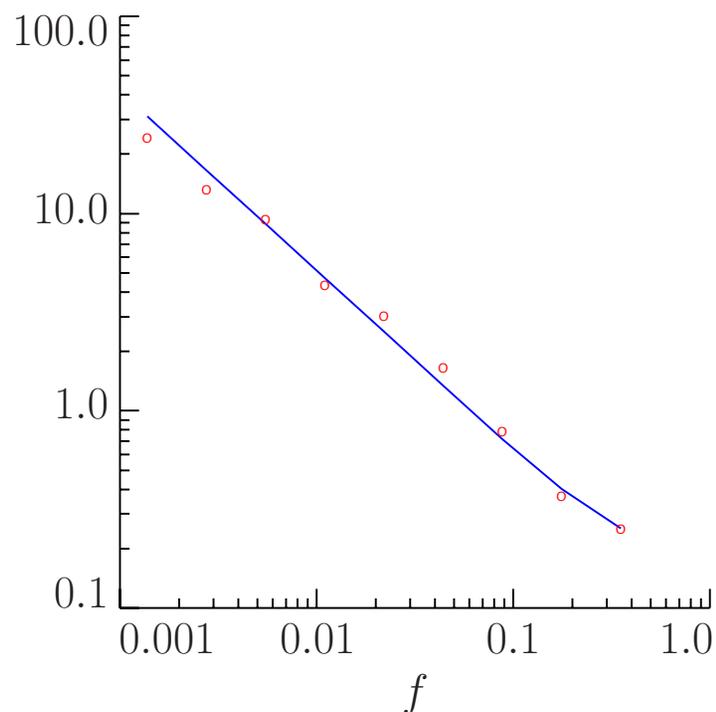
- left-hand plot: annual minima of Nile River
- new measuring device introduced in year 715
- right: Haar  $\hat{\nu}_X^2(\tau_j)$  before (x's) and after (o's) year 715.5, with 95% confidence intervals based upon  $\chi_{\eta_3}^2$  approximation

## Example – Annual Minima of Nile River: II



- based upon last 512 values (years 773 to 1284), plot shows  $\tilde{l}(\delta | \mathbf{X})$  versus  $\delta$  for the first wavelet-based approximate MLE using the LA(8) wavelet (**upper curve**) and corresponding curve for exact MLE (**lower**)
  - wavelet-based approximate MLE is value minimizing **upper curve**:  $\tilde{\delta} \doteq 0.4532$
  - exact MLE is value minimizing **lower** curve:  $\hat{\delta} \doteq 0.4452$

## Example – Annual Minima of Nile River: III



- using last 512 values again, variance of wavelet coefficients computed via LA(8) MLEs  $\tilde{\delta}$  and  $\sigma_{\varepsilon}^2(\tilde{\delta})$  (solid curve) as compared to sample variances of LA(8) wavelet coefficients (circles)
- agreement is almost too good to be true!

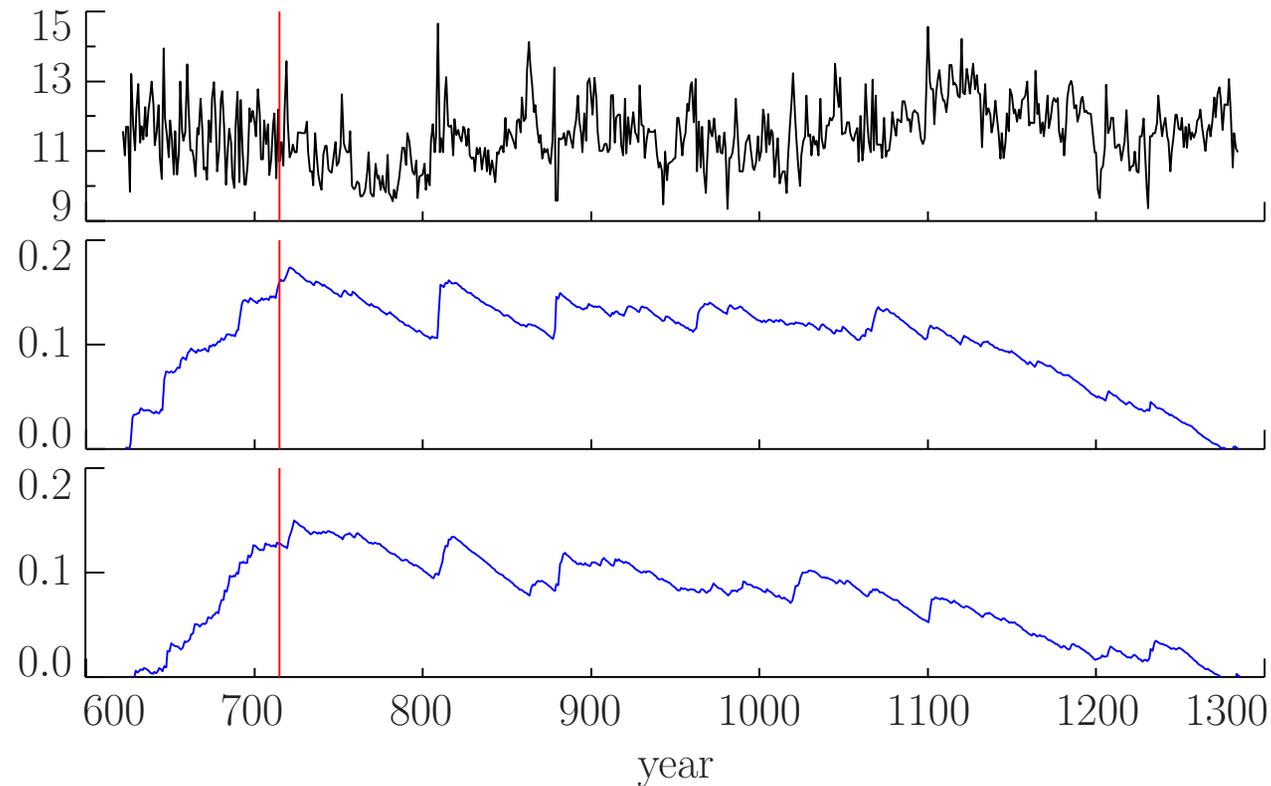
## Example – Annual Minima of Nile River: IV

- results of testing all Nile River minima for homogeneity of variance using the Haar wavelet filter with critical values determined by computer simulations

| $\tau_j$ | $M'_j$ | $D$    | critical levels |        |        |
|----------|--------|--------|-----------------|--------|--------|
|          |        |        | 10%             | 5%     | 1%     |
| 1 year   | 331    | 0.1559 | 0.0945          | 0.1051 | 0.1262 |
| 2 years  | 165    | 0.1754 | 0.1320          | 0.1469 | 0.1765 |
| 4 years  | 82     | 0.1000 | 0.1855          | 0.2068 | 0.2474 |
| 8 years  | 41     | 0.2313 | 0.2572          | 0.2864 | 0.3436 |

- can reject null hypothesis of homogeneity of variance at level of significance 0.05 for scales  $\tau_1$  &  $\tau_2$ , but not at larger scales

## Example – Annual Minima of Nile River: V



- Nile River minima (top plot) along with curves (constructed per Equation (382)) for scales  $\tau_1$  &  $\tau_2$  (middle & bottom) to identify change point via time of maximum deviation (vertical lines denote year 715)

## Summary

- wavelets approximately decorrelate LMPs
- leads to practical and flexible schemes for simulating LMPs
- also leads to schemes for estimating parameters of LMPs
  - approximate maximum likelihood estimators
  - weighted least squares estimator
- can also devise wavelet-based tests for
  - homogeneity of variance
  - trends (see Section 9.4 & Craigmile *et al.*, *Environmetrics*, 15, 313–35, 2004, for details)